

FDMS037N08B N-Channel PowerTrench[®] MOSFET

FDMS037N08B N-Channel PowerTrench[®] MOSFET 75 V, 100 A, 3.7 mΩ

Features

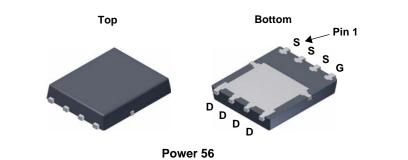
- $R_{DS(on)} = 3.01 m\Omega (Typ.) @ V_{GS} = 10 V, I_D = 50 A$
- Low FOM R_{DS(on)}*Q_G
- Low Reverse Recovery Charge, Q_{rr} = 80 nC
- Soft Reverse Recovery Body Diode
- Enables Highly Efficiency in Synchronous Rectification
- Fast Switching Speed
- 100% UIL Tested
- RoHS Compliant

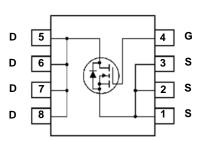
Description

This N-Channel MOSFET is produced using Fairchild Semiconductor[®]'s advance PowerTrench[®] process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- Battery Protection circuit
- DC Motor Drives and Uninterruptible Power Supplies





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted*

| Symbol | | Parameter | | FDMS037N08B | Unit |
|-----------------------------------|---------------------------------|--|----------|-------------|------|
| V _{DSS} | Drain to Source Voltage | | | 75 | V |
| V _{GSS} | Gate to Source Voltage | | | ±20 | V |
| I _D | | - Continuous ($T_C = 25^{\circ}C$) | | 100 | |
| | Drain Current | - Continuous (T _C = 25 ^o C, Silicon Limited) | | 128 | А |
| | | - Continuous ($T_A = 25^{\circ}C$) | (Note 1) | 19.9 | |
| I _{DM} | Drain Current | - Pulsed | (Note 2) | 400 | А |
| E _{AS} | Single Pulsed Avalanche Energy | | (Note 3) | 180.6 | mJ |
| P _D | Power Dissipation | $(T_{C} = 25^{\circ}C)$ | | 104.2 | W |
| | | $(T_{A} = 25^{\circ}C)$ | (Note 1) | 0.83 | W |
| T _J , T _{STG} | Operating and Storage Temperatu | re Range | | -55 to +150 | °C |

Thermal Characteristics

| Symbol | Parameter | FDMS037N08B | Unit | | |
|---------------------|---|-------------|------|--|--|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case, Max. | 1.2 | °C/W | | |
| $R_{	ext{	heta}JA}$ | Thermal Resistance, Junction to Ambient, Max. (Note 2 |) 50 | °C/W | | |

| D8B FDMS037N08B Characteristics T _J = 2 Parameter eristics | Power 56 25°C unless oth | 13 " | 12 | | | | |
|--|---|--|---|---|--|--|---|
| Parameter | 25°C unless oth | | 14 | 2 mm | | Quantity 3000 units | |
| Parameter | | nerwise noted | | | i | | |
| eristics | | Test Conditions | | Min. | Тур. | Max. | Unit |
| | | | | | | | |
| Drain to Source Breakdown Voltage | | I _D = 250μA, V _{GS} = 0V | | 75 | - | - | V |
| Breakdown Voltage Temperature | | $I_D = 250 \mu A$, Referenced to $25^{\circ}C$ | | - | 39 | - | mV/º0 |
| | Itage Drain Current $V_{PQ} = 60V_{PQ}$ | | $r_{e} = 0V$ - | | - | 1 | μA |
| | | | | - | - | | nA |
| | | | | | | | |
| | | $V_{aa} = V_{aa}$ $I_a = 250 \mu \Delta$ | | 25 | _ | 4.5 | V |
| - | | | | 2.5 | | | mΩ |
| | | | | | | - | S |
| | | v DS = 10 v, 10 = 00/ v | | | 100 | | 0 |
| Input Capacitance | | V _{DS} = 37.5V, V _{GS} = 0V f = 1MHz | | - | 4550 | 5915 | pF |
| Output Capacitance | | | | - | 1060 | 1380 | pF |
| Reverse Transfer Capacitance | I | | | - | 30.2 | 45 | pF |
| Energy Releted Output Capaci | tance | V _{DS} = 37.5V, V _{GS} = 0V | | - | 1702 | - | pF |
| Total Gate Charge at 10V | | $V_{DS} = 37.5V, I_D = 50A$ $V_{GS} = 0V \text{ to } 10V$ | | - | 76.8 | 100 | nC |
| Gate to Source Gate Charge | | | | - | 27.5 | - | nC |
| Gate to Drain "Miller" Charge | | | | - | 17.4 | - | nC |
| Gate Plateau Volatge | | 1) | Note 4) | - | 5.1 | - | V |
| Total Gate Charge Sync. | , v | $V_{\rm DS} = 0V, I_{\rm D} = 50A \tag{1}$ | Note 5) | - | 66.3 | - | nC |
| Output Charge | N N | V _{DS} = 37.5V, V _{GS} = 0V | | - | 74.6 | - | nC |
| haracteristics | | | | | | | |
| Turn-On Delay Time | | V_{DD} = 37.5V, I _D = 50A V_{GS} = 10V, R _{GEN} = 4.7Ω | | - | 34.9 | 80 | ns |
| Turn-On Rise Time | | | | - | 20.1 | 50 | ns |
| Turn-Off Delay Time | | | | - | 55.3 | 120 | ns |
| Turn-Off Fall Time | | (1 | Note 4) | - | 19.4 | 49 | ns |
| Equivalent Series Resistance | f | f = 1MHz | | - | 1.28 | - | Ω |
| e Diode Characteristics | 5 | | | | | | |
| Maximum Continuous Drain to Source Diode Forward Current | | | | - | - | 100 | Α |
| Maximum Pulsed Drain to Sour | ce Diode Forw | ard Current | | - | - | 400 | Α |
| Drain to Source Diode Forward | Voltage | $V_{GS} = 0V, I_{SD} = 50A$ | | - | - | 1.3 | V |
| | 1 | $V_{GS} = 0V, I_{SD} = 50A$ $dI_F/dt = 100A/\mu s$ | | - | 66.8 | - | ns |
| Reverse Recovery Time | | | | - | 84 | | nC |
| | Gate to Body Leakage Current eristics Gate Threshold Voltage Static Drain to Source On Resi Forward Transconductance aracteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Energy Releted Output Capaci Total Gate Charge at 10V Gate to Source Gate Charge Gate to Drain "Miller" Charge Gate to Drain "Miller" Charge Gate Plateau Volatge Total Gate Charge Sync. Output Charge haracteristics Turn-On Delay Time Turn-Off Delay Time Turn-Off Fall Time Equivalent Series Resistance e Diode Characteristics Maximum Continuous Drain to Maximum Pulsed Drain to Sour | Coencient Zero Gate Voltage Drain Current Gate to Body Leakage Current Gate to Body Leakage Current Pristics Gate Threshold Voltage Static Drain to Source On Resistance Forward Transconductance aracteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Energy Releted Output Capacitance Total Gate Charge at 10V Gate to Source Gate Charge Gate to Drain "Miller" Charge Gate to Drain "Miller" Charge Gate Charge Sync. 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2. Repetitive Rating: Pulse width limited by maximum junction temperature

3. L = 0.3mH, I_{AS} = 34.7A, Starting T_J = 25°C

4. Essentially Independent of Operating Temperature Typical Characteristics 5. See the test circuit in page 8

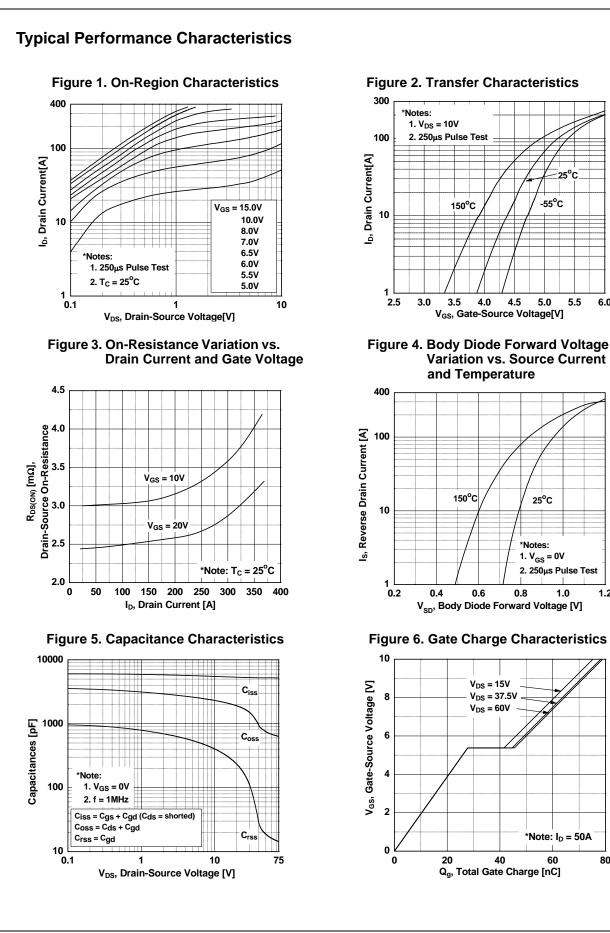
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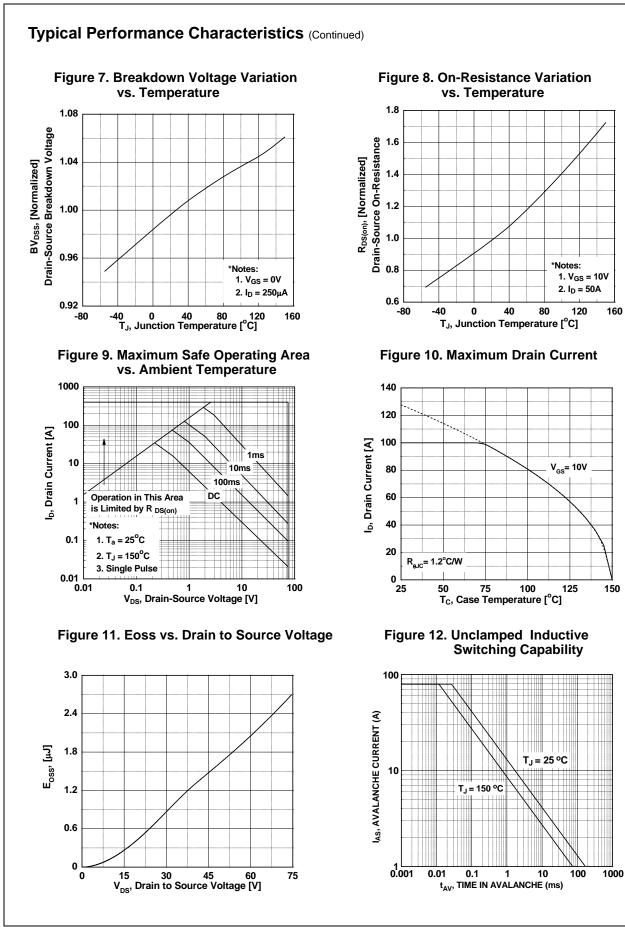
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1.2

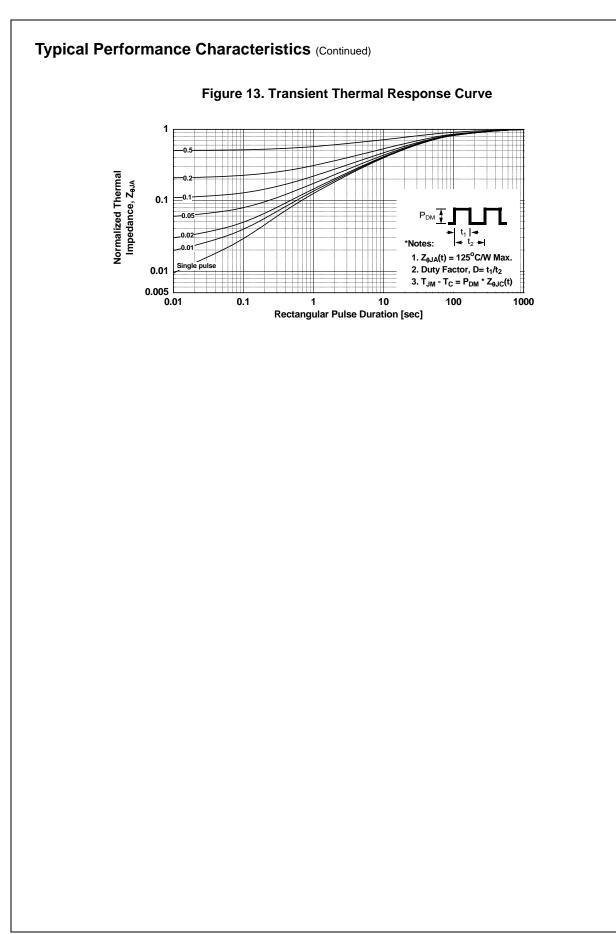


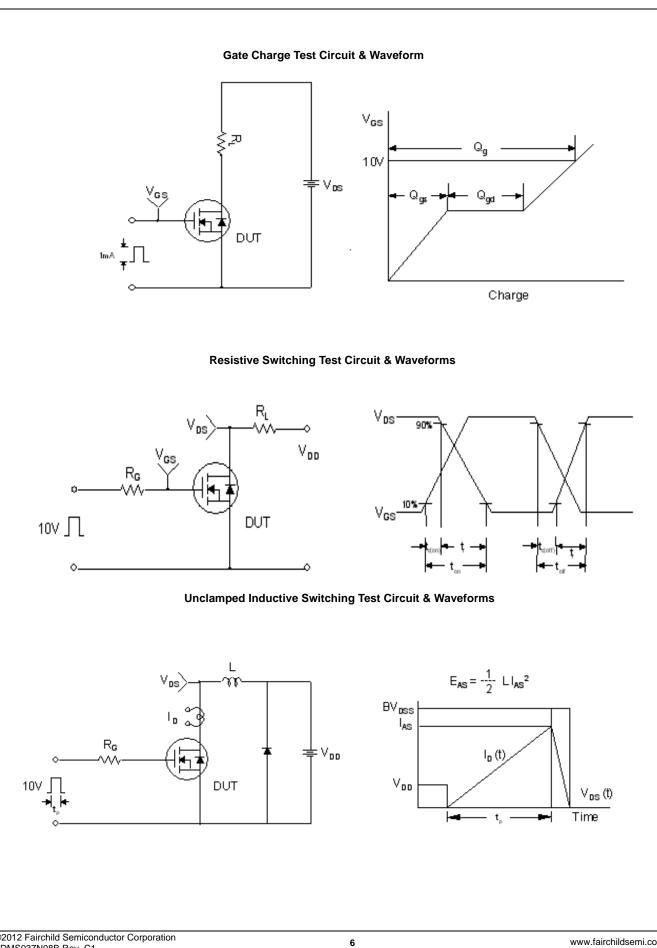
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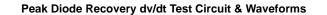
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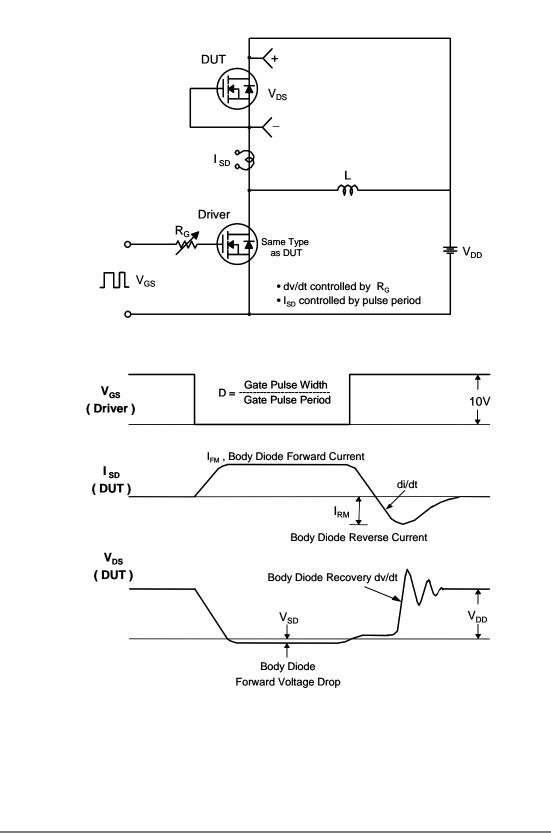




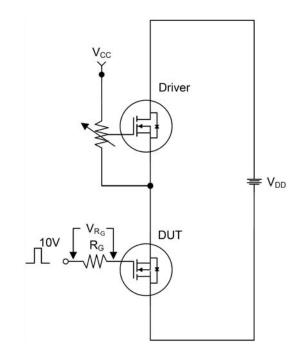
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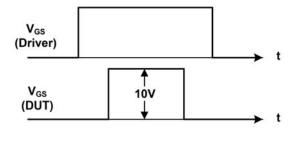
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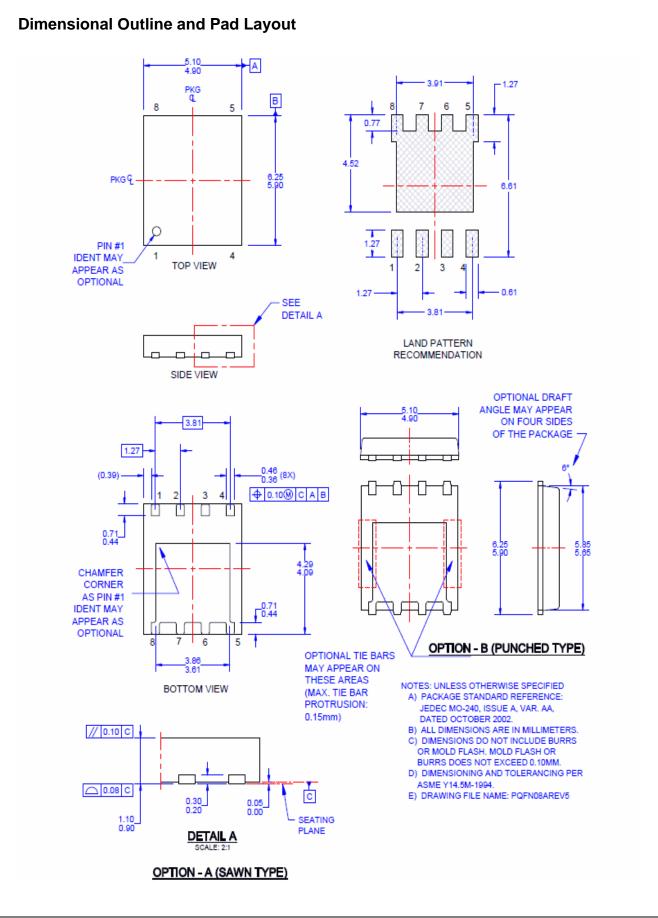


Total Gate Charge Qsync. Test Circuit & Waveforms





$$Qsync = \frac{1}{R_G} \cdot \int V_{R_G}(t) dt$$



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